Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/728,394	HANSON, KIM ANN	
Examiner	Art Unit	
Luan K. Bui	3728	

	SEARCHED						
	JEAN	CHED .	т				
Class	Subclass	Date	Examiner				
206	440, 441	12/14/2005	LKB				
	459.1						
	459.5						
	494, 730						
	732-735						
604	358						
	385.02						
	385.19						

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
·					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
	1			
		J		